Notice of References Cited

Application/Control No.

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Examiner

Vivian Chen

Applicant(s)/Patent Under Reexamination DEY ET AL.

Art Unit
1773

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2003/0099789	05-2003	Dey et al.	428/31
	В	US-4,996,086	02-1991	Gerlowski et al.	427/421
	С	US-5,369,180	11-1994	Machado et al.	525/185
	D	US-5,883,188	.03-1999	Hwang et al.	525/71
	Е	US-5,284,693	02-1994	Spain et al.	428/172
	F	US-4,902,557	02-1990	Rohrbacher, Frank	428/215
	G	US-4,330,858	05-1982	Choquet, Michel F.	370/528
	Н	US-5,750,234	05-1998	Johnson et al.	428/141
	ı	US-4,692,357	09-1987	Mayumi et al.	427/393.5
	J	US-4,883,834	11-1989	Yamamoto et al.	524/504
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z	JP 05-271332	10-1993	JP	Inaba et al	
	0					
	Р					
	ø					
	R					
	S					
	Τ					

NON-PATENT DOCUMENTS

	HON-T ATEN DOCUMENTS							
*	* Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)							
	U							
	V							
	w							
	х							

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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